

**Accelerated moisture resistance –
Unbiased HAST**

Withdrawing

iTech Standards
(<http://standards.iteh.ai>)
Document Preview

<https://standards.iteh.ai/catalog/standards/iec/1a50eccd-d7b1-4ab5-bad0-bb778613624c/iec-pas-62336-2002>

PUBLICLY AVAILABLE SPECIFICATION



INTERNATIONAL
ELECTROTECHNICAL
COMMISSION



Reference number
IEC/PAS 62336

Withdrawn

iTech Standards
(<http://standards.iteh.ai>)
Document Preview

IEC PAS 62336:2002

<https://standards.iteh.ai/catalog/standards/iec/1a50eccd-d7b1-4ab5-bad0-bb778613624c/iec-pas-62336-2002>

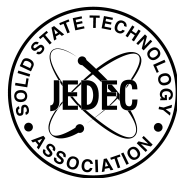
JEDEC STANDARD

Accelerated Moisture Resistance - Unbiased HAST

JESD22-A118

DECEMBER 2000

JEDEC SOLID STATE TECHNOLOGY ASSOCIATION



Withdrawn

iTech Standards
(<http://standards.itech.ai>)
Document Preview

IEC PAS 62336:2002

<https://standards.itech.ai/catalog/standards/iec/1a50eccd-d7b1-4ab5-bad0-bb778613624c/iec-pas-62336-2002>

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**ACCELERATED MOISTURE RESISTANCE –
UNBIASED HAST**

FOREWORD

A PAS is a technical specification not fulfilling the requirements for a standard, but made available to the public and established in an organization operating under given procedures.

IEC-PAS 62336 was submitted by JEDEC and has been processed by IEC technical committee 47: Semiconductor devices.

The text of this PAS is based on the following document:

This PAS was approved for publication by the P-members of the committee concerned as indicated in the following document:

Draft PAS	Report on voting
47/1635/PAS	47/1645RVD

Following publication of this PAS, the technical committee or subcommittee concerned will investigate the possibility of transforming the PAS into an International Standard.

An IEC-PAS licence of copyright and assignment of copyright has been signed by the IEC and JEDEC and is recorded at the Central Office.

This PAS shall remain valid for no longer than 3 years starting from 2002-08. The validity may be extended for a single 3-year period, following which it shall be revised to become another type of normative document, or shall be withdrawn.

- 1) The IEC (International Electrotechnical Commission) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of the IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, the IEC publishes International Standards. Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. The IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of the IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested National Committees.
- 3) The documents produced have the form of recommendations for international use and are published in the form of standards, technical specifications, technical reports or guides and they are accepted by the National Committees in that sense.
- 4) In order to promote international unification, IEC National Committees undertake to apply IEC International Standards transparently to the maximum extent possible in their national and regional standards. Any divergence between the IEC Standard and the corresponding national or regional standard shall be clearly indicated in the latter.
- 5) The IEC provides no marking procedure to indicate its approval and cannot be rendered responsible for any equipment declared to be in conformity with one of its standards.
- 6) Attention is drawn to the possibility that some of the elements of this PAS may be the subject of patent rights. The IEC shall not be held responsible for identifying any or all such patent rights.

NOTICE

JEDEC standards and publications contain material that has been prepared, reviewed, and approved through the JEDEC Board of Directors level and subsequently reviewed and approved by the EIA General Counsel.

JEDEC standards and publications are designed to serve the public interest through eliminating misunderstandings between manufacturers and purchasers, facilitating interchangeability and improvement of products, and assisting the purchaser in selecting and obtaining with minimum delay the proper product for use by those other than JEDEC members, whether the standard is to be used either domestically or internationally.

JEDEC standards and publications are adopted without regard to whether or not their adoption may involve patents or articles, materials, or processes. By such action JEDEC does not assume any liability to any patent owner, nor does it assume any obligation whatever to parties adopting the JEDEC standards or publications.

The information included in JEDEC standards and publications represents a sound approach to product specification and application, principally from the solid state device manufacturer viewpoint. Within the JEDEC organization there are procedures whereby a JEDEC standard or publication may be further processed and ultimately become an ANSI/EIA standard.

No claims to be in conformance with this standard may be made unless all requirements stated in the standard are met.

Inquiries, comments, and suggestions relative to the content of this JEDEC standard or publication should be addressed to JEDEC Solid State Technology Association, 2500 Wilson Boulevard, Arlington, VA 22201-3834, (703)907-7560/7559 or www.jedec.org

Published by
JEDEC Solid State Technology Association 2000
2500 Wilson Boulevard
Arlington, VA 22201-3834